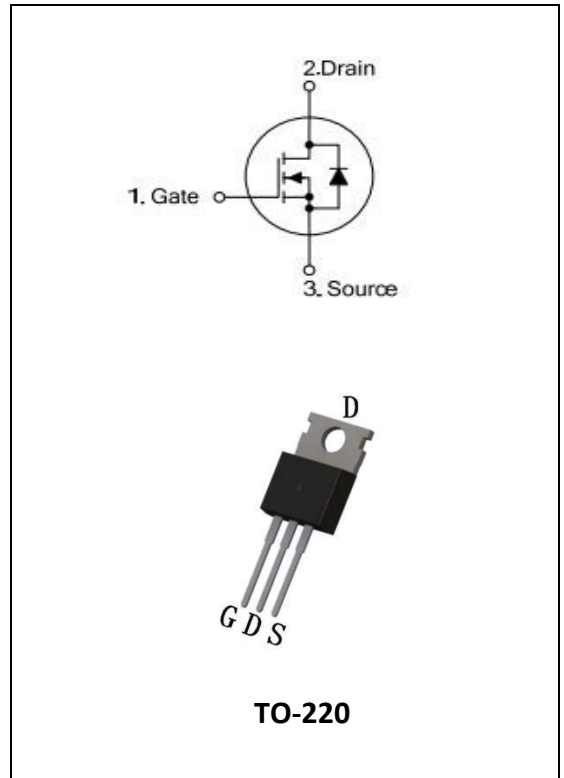


Silicon N-Channel Power MOSFET

Description

IRF3205, the silicon N-channel Enhanced MOSFETS, is obtained by advanced MOSFET technology which reduce the conduction loss, improve switching performance and enhance the avalanche energy. The transistor is suitable device for Synchronous Rectification, inverter systems, high speed switching and general purpose applications.



KEY CHARACTERISTICS

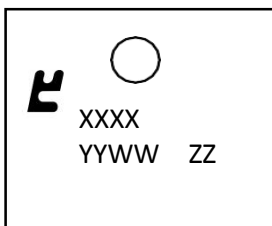
- ① $V_{DS}=55V, I_D=110A$ $R_{DS(ON)} < 9m\Omega @ V_{GS}=10V$
- ② Fast Switching
- ③ Low C_{rss}
- ④ 100% avalanche tested
- ⑤ Improved dv/dt capability
- ⑥ RoHS product

APPLICATIONS

- ① Power management for 12V inverter systems
- ② Synchronous Rectification

ORDERING INFORMATION

| Ordering Codes | Package | Product Code | Packing |
|----------------|---------|--------------|---------|
| IRF3205 | TO-220 | IRF3205 | Tube |

| | |
|--|---|
| <p>IRF3205</p>  <div style="border: 1px solid black; padding: 5px; margin-top: 10px;"> <p>(2) Package type</p> <p>(1) Chip name</p> </div> <p>(1) IRF3205:55V 110A (2) Package type:TO-220</p> | <p>XXXX: Product Code</p> <p>YYWW: Year&Week</p> <p>ZZ: Assembly Code</p> |
|--|---|

ABSOLUTE RATINGS at TC = 25°C, unless otherwise specified

| Symbol | Parameter | Rating | Units |
|-----------------------------------|--|-----------------|-------|
| V _{DSS} | Drain-to-Source Voltage | 55 | V |
| I _D | Continuous Drain Current | 110 | A |
| | Continuous Drain Current TC = 100 °C | 80 | A |
| I _{DM} | Pulsed Drain Current(Note1) | 440 | A |
| V _{GS} | Gate-to-Source Voltage | ±20 | V |
| E _{AS} | Single Pulse Avalanche Energy(Note2) | 1500 | mJ |
| I _{AR} | Avalanche Current | 25 | A |
| E _{AR} | Repetitive Avalanche Current | 20 | mJ |
| dv/dt | Peak Diode Recovery dv/dt(Note3) | 5.0 | V/ns |
| P _D | Power Dissipation TO-220 | 210 | W |
| | Derating Factor above 25°C | 1.25 | W/°C |
| T _J , T _{stg} | Operating Junction and Storage Temperature Range | 175, -55 to 175 | °C |
| T _L | Maximum Temperature for Soldering | 300 | °C |

Thermal characteristics

Thermal characteristics (No FullPAK) TO-220

| Symbol | Parameter | RATINGS | Units |
|------------------|---------------------|---------|-------|
| R _{θJC} | Junction-to-Case | 0.75 | °C/W |
| R _{θJA} | Junction-to-Ambient | 62.5 | °C/W |

Electrical Characteristics at TC = 25°C, unless otherwise specified

| OFF Characteristics | | | | | | |
|-------------------------------------|-----------------------------------|---|--------|-------|------|-------|
| Symbol | Parameter | Test Conditions | Values | | | Units |
| | | | Min. | Typ. | Max. | |
| V _{DSS} | Drain to Source Breakdown Voltage | V _{GS} =0V, I _D =250μA | 55 | -- | -- | V |
| ΔBV _{DSS} /ΔT _J | Bvdss Temperature Coefficient | I _D =250uA, Reference 25°C | -- | 0.055 | -- | V/°C |
| I _{DSS} | Drain to Source Leakage Current | V _D S =55V, V _G S= 0V, T _j = 25°C | -- | -- | 1 | μA |
| | | V _D S =44V, V _G S= 0V, T _j = 125°C | -- | -- | 10 | μA |
| I _{GSS(F)} | Gate to Source Forward Leakage | V _G S =+20V | -- | -- | 100 | nA |



| | | | | | | |
|---------|--------------------------------|-----------------|----|----|-----|----|
| IGSS(R) | Gate to Source Reverse Leakage | $V_{GS} = -20V$ | -- | -- | 100 | nA |
|---------|--------------------------------|-----------------|----|----|-----|----|

| ON Characteristics | | | | | | |
|--------------------|--------------------------------|--|--------|------|------|-------|
| Symbol | Parameter | Test Conditions | Values | | | Units |
| | | | Min. | Typ. | Max. | |
| $R_{DS(ON)}$ | Drain-to-Source On- Resistance | $V_{GS}=10V,$ $I_D=40A$ | -- | 7.2 | 9 | mΩ |
| $V_{GS(TH)}$ | Gate Threshold Voltage | $V_{DS} = V_{GS},$ $I_D = 250\mu A$ | 2 | -- | 4 | V |
| gfs | Forward Transconductance | $V_{DS}=20V,$ $I_D=40A(Notes4)$ | -- | 65 | -- | S |

| Dynamic Characteristics | | | | | | |
|-------------------------|------------------------------|--|--------|------|------|-------|
| Symbol | Parameter | Test Conditions | Values | | | Units |
| | | | Min. | Typ. | Max. | |
| R_g | Gate resistance | $f = 1.0MHz$ | -- | 1.7 | -- | Ω |
| C_{iss} | Input Capacitance | $V_{GS} = 0V V_{DS} = 25V$ $f = 1.0MHz$ | -- | 3247 | -- | PF |
| C_{oss} | Output Capacitance | | -- | 781 | -- | |
| C_{rss} | Reverse Transfer Capacitance | | -- | 211 | -- | |

| Switching Characteristics | | | | | | |
|---------------------------|---------------------------------|--|--------|------|------|-------|
| Symbol | Parameter | Test Conditions | Values | | | Units |
| | | | Min. | Typ. | Max. | |
| $t_d(ON)$ | Turn-on Delay Time | $I_D = 62A$ $V_{DD} = 28V$ $V_{GS} = 10V$ $R_G = 4.5\Omega$ | -- | 14 | -- | ns |
| t_r | Rise Time | | -- | 101 | -- | |
| $t_d(OFF)$ | Turn-Off Delay Time | | -- | 50 | -- | |
| t_f | Fall Time | | -- | 65 | -- | |
| Q_g | Total Gate Charge | $I_D = 62A$ $V_{DD} = 44V$ $V_{GS} = 10V$ | -- | 146 | -- | nC |
| Q_{gs} | Gate to Source Charge | | -- | 10 | -- | |
| Q_{gd} | Gate to Drain ("Miller") Charge | | -- | 17.5 | -- | |

| Source-Drain Diode Characteristics | | | | | | |
|------------------------------------|--|--------------------------|--------|------|------|-------|
| Symbol | Parameter | Test Conditions | Values | | | Units |
| | | | Min. | Typ. | Max. | |
| I_S | Continuous Source Current (Body Diode) | $T_C = 25^\circ C$ | -- | -- | 110 | A |
| I_{SM} | Maximum Pulsed Current (Body Diode) | | -- | -- | 440 | A |
| V_{SD} | Diode Forward Voltage | $I_S = 62A, V_{GS} = 0V$ | -- | 0.9 | 1.3 | V |

| | | | | | | |
|-----|-------------------------|---|----|-----|----|----|
| Trr | Reverse Recovery Time | $I_S=62A,$ $T_j = 25^\circ C$ $d_{IF}/d_t=100A/us, V_{GS}=0V$ | -- | 69 | -- | ns |
| Qrr | Reverse Recovery Charge | | -- | 143 | -- | nC |

Note1:Pulse width limited by maximum junction temperature

Note2: $L=1mH, V_{DS}=44V, Start T_j=25^\circ C$

Note3: $I_{SD}\leq 110A, d_i/d_t \leq 300A/us, V_{DD}\leq BV_{DS}, Start T_j=25^\circ C$

Note4:Pulse width $tp\leq 300\mu s, \delta\leq 2\%$

Characteristics Curves

Figure 1 Safe Operating Area

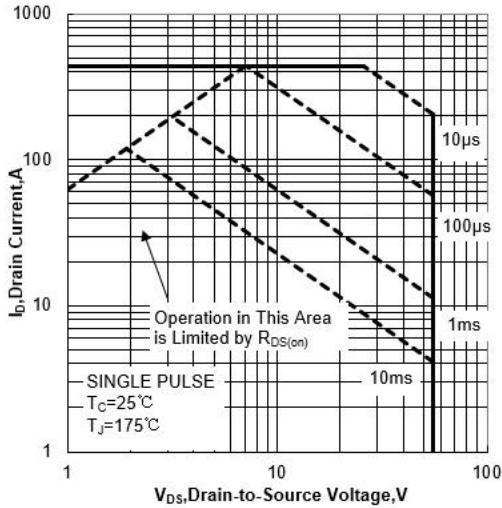


Figure 2 Max Thermal Impedance

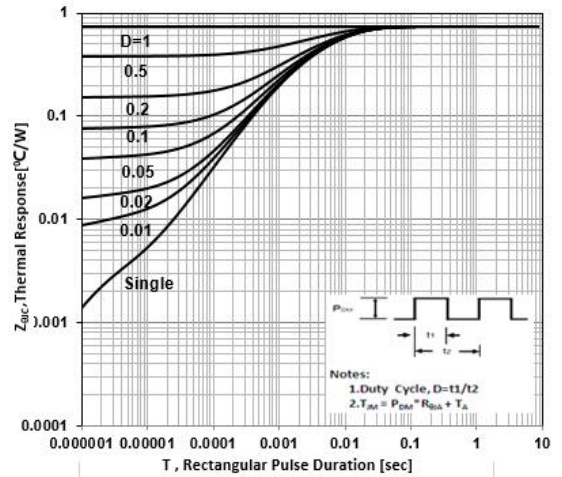


Figure 3 Typical Output Characteristics

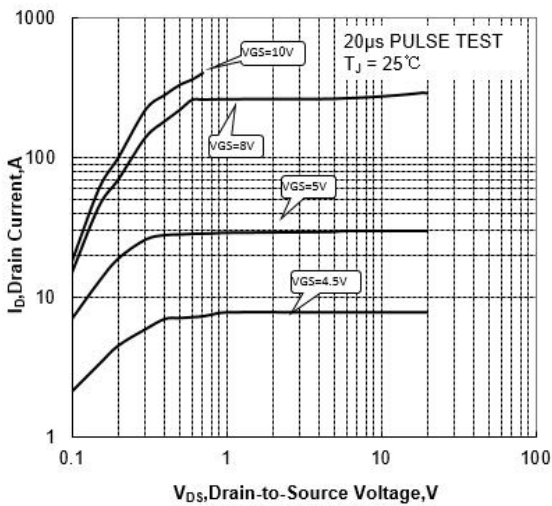


Figure 4 Typical Output Characteristics

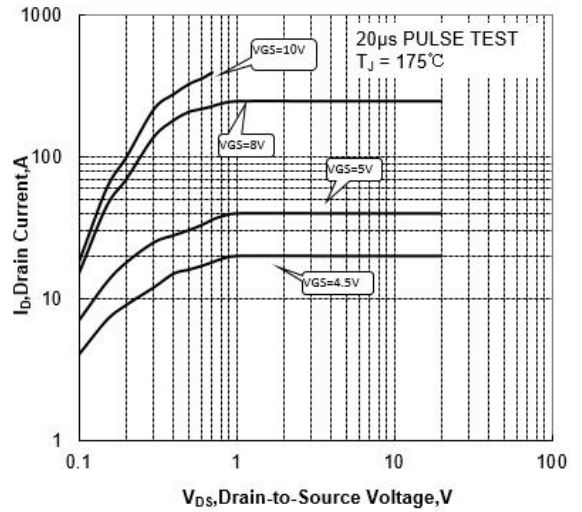


Figure 5 Typical Transfer Characteristics

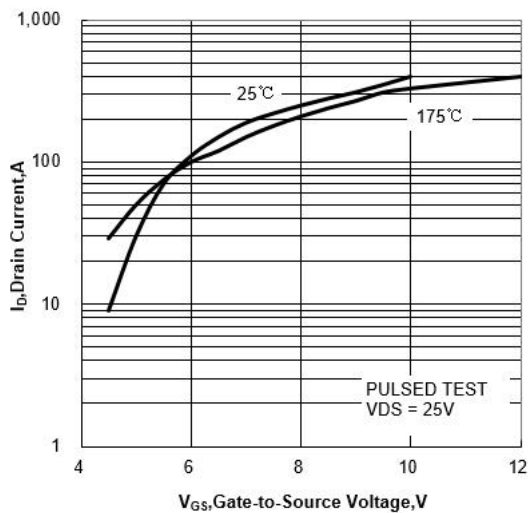


Figure 6 Typical Drain to Source on Resistance vs Junction Temperature

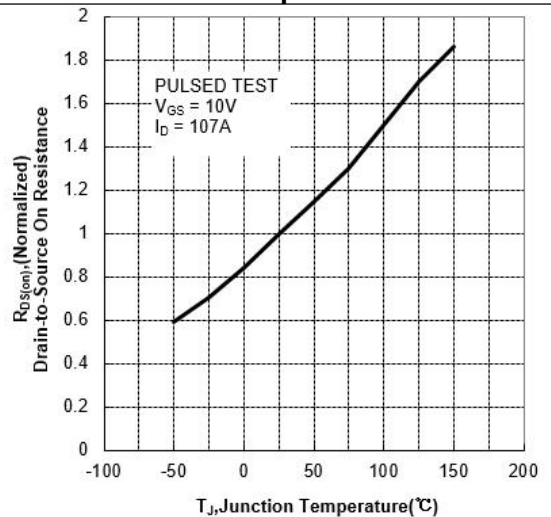


Figure 7 Maximum Drain Current vs Case Temperature

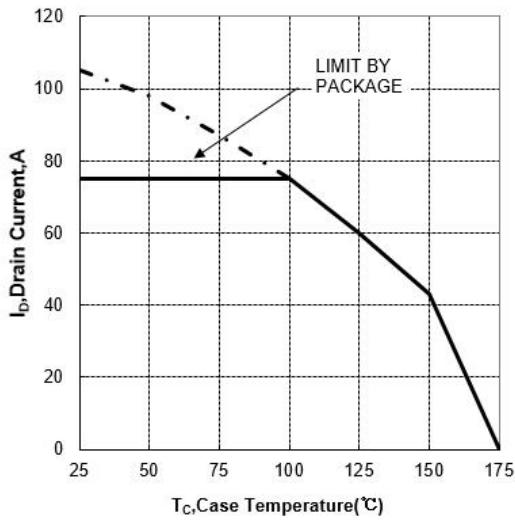


Figure 8 Typical Source-Drain Diode Forward Voltage

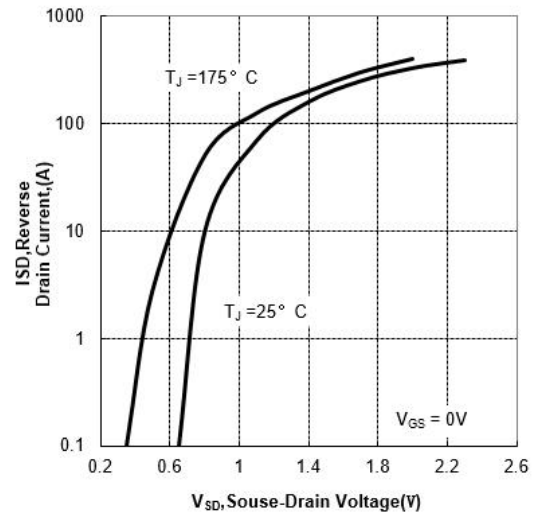


Figure 9 Typical Capacitance vs Drain-to-Source Voltage

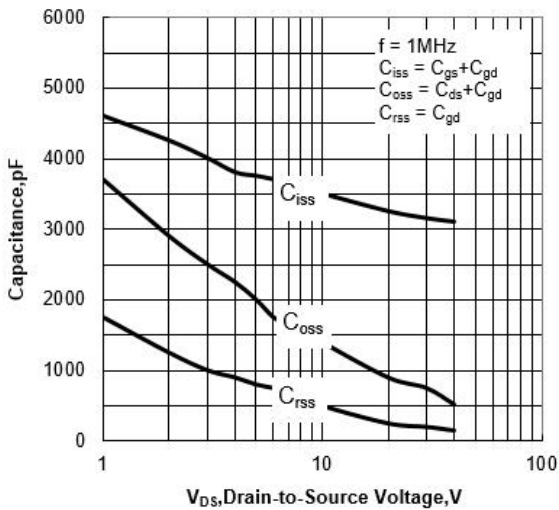
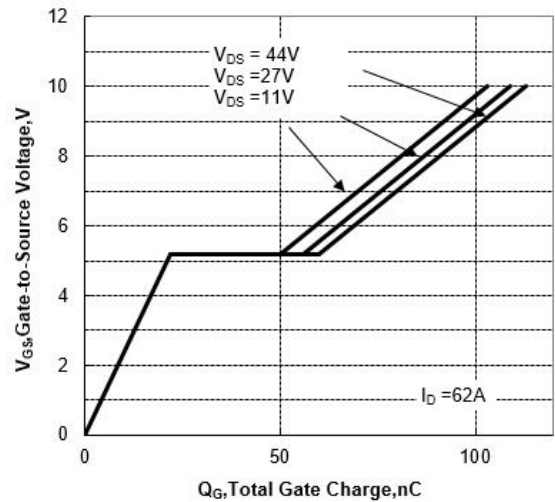


Figure 10 Typical Gate Charge vs Gate-to-Source Voltage



Test Circuit and Waveform

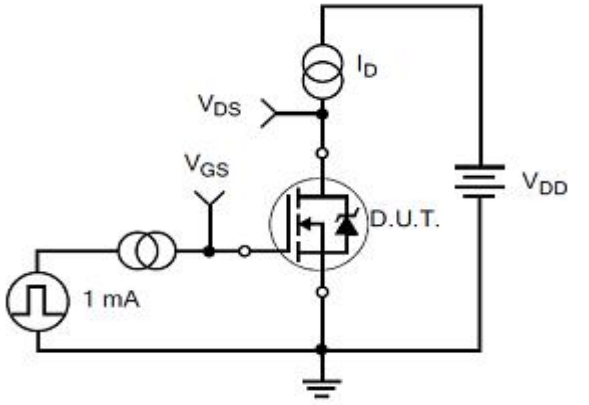
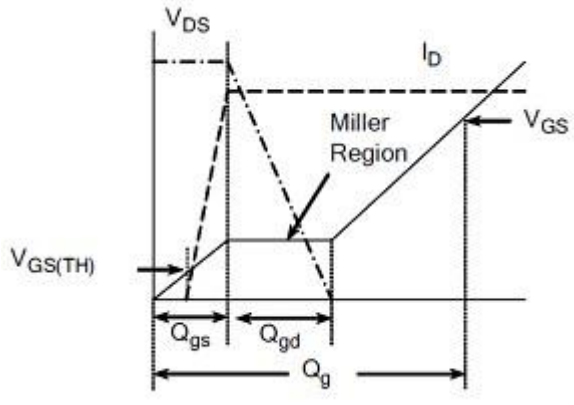
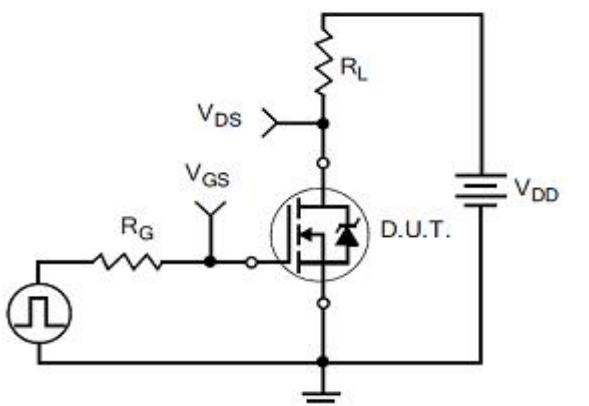
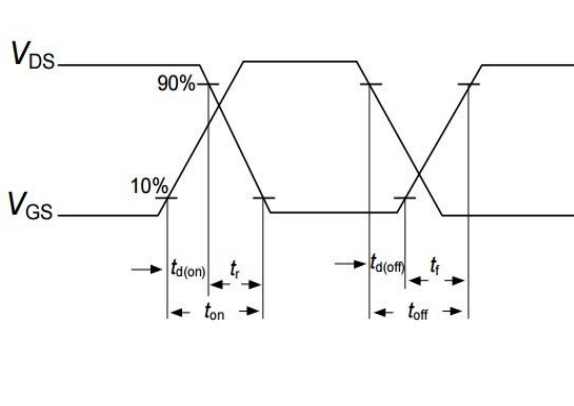
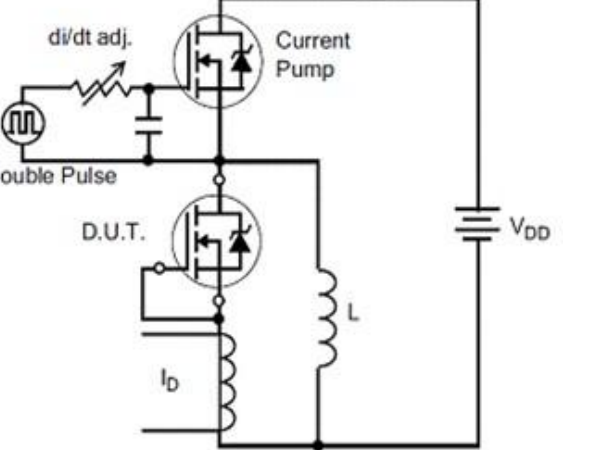
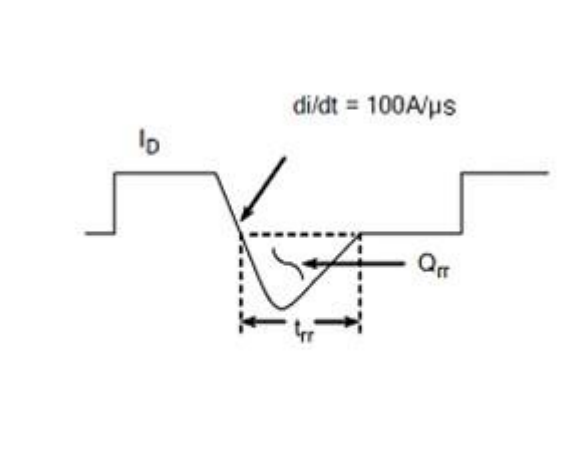
| | |
|---|--|
| <p>Figure 12 Gate Charge Test Circuit</p>  | <p>Figure 13 Gate Charge Waveforms</p>  |
| <p>Figure 14 Resistive Switching Test Circuit</p>  | <p>Figure 15 Resistive Switching Waveforms</p>  |
| <p>Figure 16 Diode Reverse Recovery Test Circuit</p>  | <p>Figure 17 Diode Reverse Recovery Waveform</p>  |

Figure 18 Unclamped Inductive Switching Test

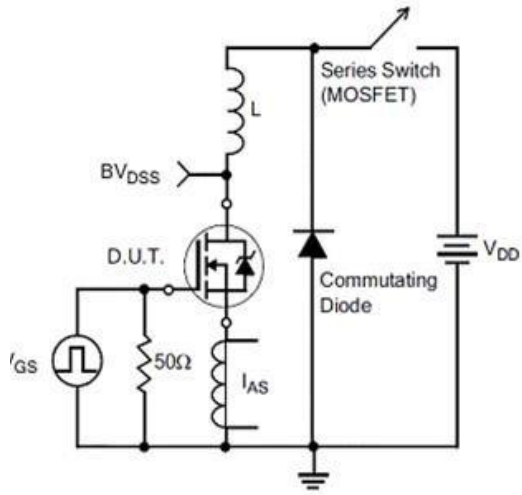
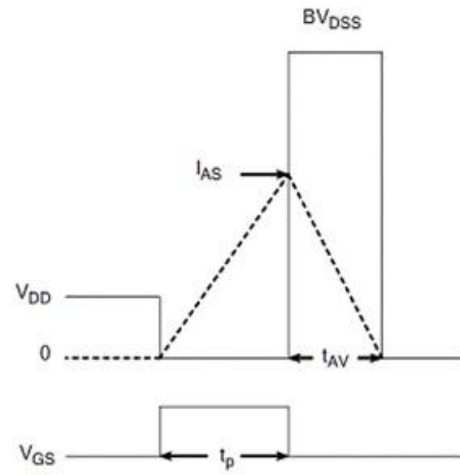
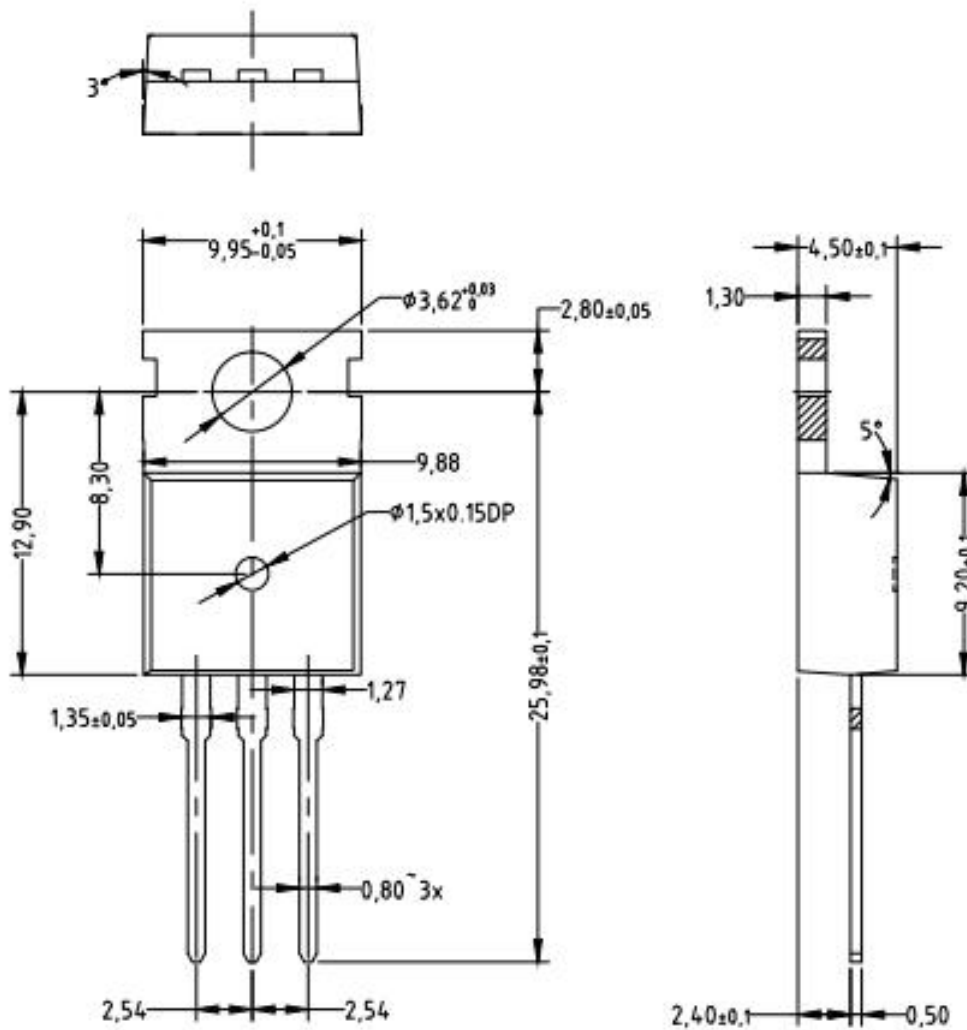


Figure 19 Unclamped Inductive Switching



Package Description



TO-220 Package



NOTE:

1. Exceeding the maximum ratings of the device in performance may cause damage to the device, even the permanent failure, which may affect the dependability of the machine. Please do not exceed the absolute maximum ratings of the device when circuit designing.
2. When installing the heat sink, please pay attention to the torsional moment and the smoothness of the heat sink.
3. MOSFETs is the device which is sensitive to the static electricity, it is necessary to protect the device from being damaged by the static electricity when using it.
4. Shenzhen Minos reserves the right to make changes in this specification sheet and is subject to change without prior notice.

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